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ALPHA & OMEGA SEMICONDUCTOR			AOL1242 40V N-Channel MOSFE			
General Descri	ption		Product Summa	ary		
The AOL1242 uses trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Power losses are minimized due to an extremely low combination of $R_{DS(ON)}$ and Crss.In addition, switching behavior is well controlled with a "Schottky style" soft recovery body diode.			V_{DS} $I_{D} (at V_{GS}=10V)$ $R_{DS(ON)} (at V_{GS}=10V)$ $R_{DS(ON)} (at V_{GS}=4.5V)$ 100% UIS Tested 100% R _g Tested		40V 69A < 5.2mΩ < 7.9mΩ	
Absolute Maximum	UltraSO-8 TM Top View Bott	tom View				
Parameter		Symbol	Maxim	um	Units	
Drain-Source Voltage)	V _{DS}	40	40		
Gate-Source Voltage		V _{GS}	±20		V	
Continuous Drain Current ^G	T _C =25℃ T _C =100℃	I _D	69 54		A	
Pulsed Drain Current		I _{DM}	205			
Continuous Drain Current	T _A =25℃ T _A =70℃	I _{DSM}	14		- A	
Avalanche Current ^C	+	I _{AS} , I _{AR}	40		A	
Avalanche energy L=0.1mH ^C		E _{AS} , E _{AR}	80		mJ	
37 -	T _c =25℃		68 34 2.1			
Power Dissipation ^B	T _C =100℃	P _D			- W	
end Biosipation	T _A =25°C				W	
Power Dissipation ^A	T _A =70℃	P _{DSM} 2.1				
Junction and Storage Temperature Range			-55 to 175		~	
unction and Storage	remperature Range	T_J,T_STG	-55 [0	170	Ĵ	
Thermal Characteris	stics					
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to	-Ambient ^A t<10s		20	25	90/M	

Thermal Characteristics							
Parameter	Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient ^A	t ≤ 10s	D	20	25	°C/W		
Maximum Junction-to-Ambient AD	Steady-State	R _{0JA}	50	60	°C/W		
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.8	2.2	°C/W		



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		40			V
I _{DSS} Zero Gate Voltage Drain Current	V_{DS} =40V, V_{GS} =0V				1		
	Zero Gate Voltage Drain Current	T _J =55℃				5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V				100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.3	1.8	2.3	V
I _{D(ON)}	On state drain current	V_{GS} =10V, V_{DS} =5V		205			Α
	Static Drain-Source On-Resistance	V_{GS} =10V, I_{D} =20A			4.2	5.2	mΩ
			T _J =125℃		6.9	8.5	
		V_{GS} =4.5V, I_{D} =20A			6.1	7.9	mΩ
g _{FS}	Forward Transconductance	$V_{DS}=5V, I_{D}=20A$			70		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V
I _s	Maximum Body-Diode Continuous Current G					69	А
DYNAMIC	C PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =20V, f=1MHz		1080	1350	1620	pF
C _{oss}	Output Capacitance			280	405	530	pF
C _{rss}	Reverse Transfer Capacitance			7	26	45	pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		1	2	3	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge			15	19	23	nC
Q _g (4.5V)	Total Gate Charge		_20.4	5	8	11	nC
Q _{gs}	Gate Source Charge	V_{GS} =10V, V_{DS} =20V, I_{D} =20A			4.5		nC
Q_{gd}	Gate Drain Charge				2.3		nC
t _{D(on)}	Turn-On DelayTime				6		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =20V, R_{L} =1 Ω , R_{GEN} =3 Ω			2.5		ns
t _{D(off)}	Turn-Off DelayTime				23		ns
t _f	Turn-Off Fall Time				4		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs		10	15.5	21	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=500A/μs		21	31	41	nC

A. The value of R_{6JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{0JA} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(MAX)}=175^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial $T_{J} = 25^{\circ}$ C.

D. The R_{BJA} is the sum of the thermal impedance from junction to case R_{BJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

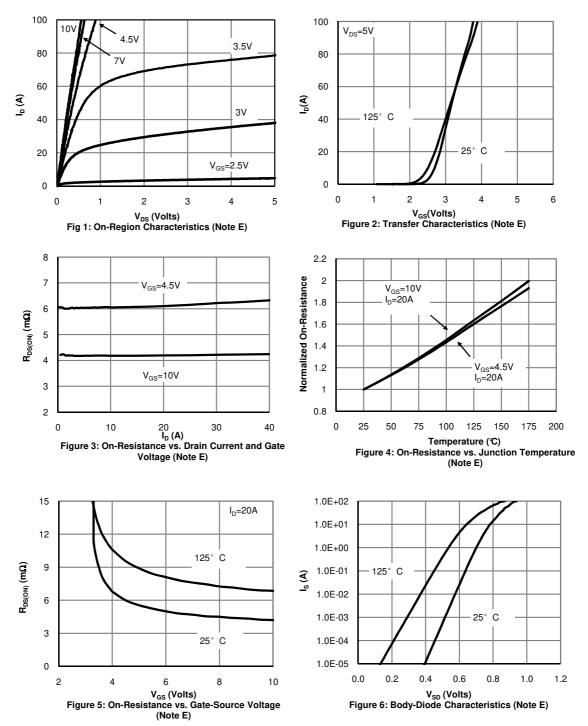
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS







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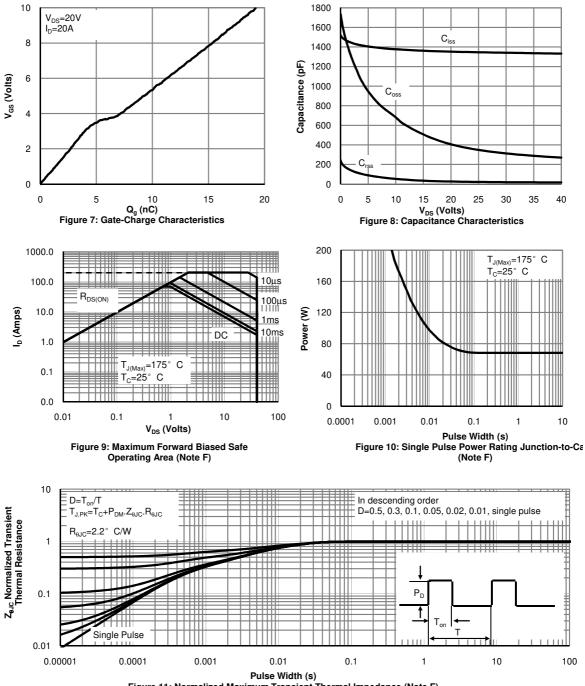
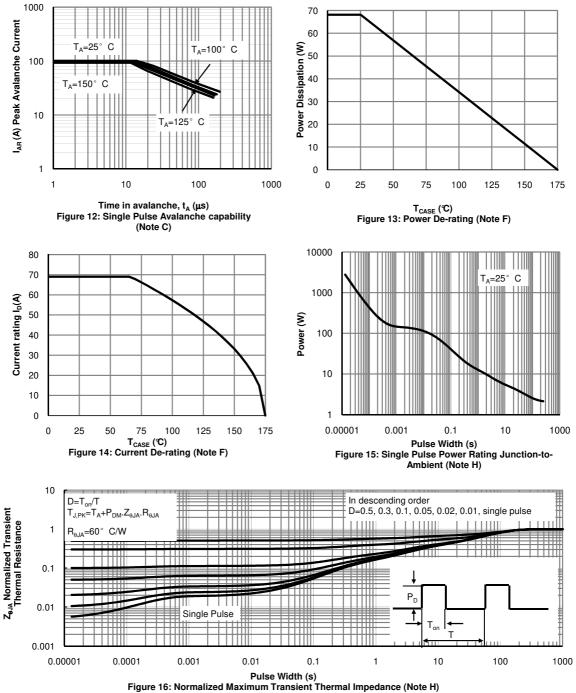


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

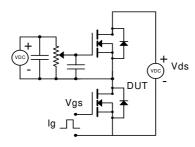


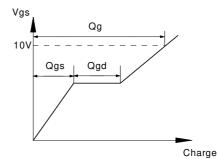
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



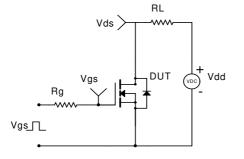


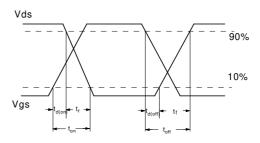
Gate Charge Test Circuit & Waveform



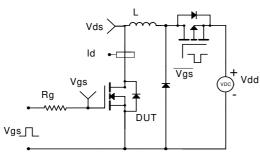


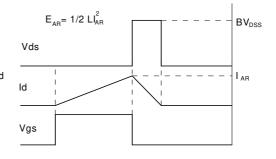
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

